



Vishay Siliconix

## N-Channel 30 V (D-S) MOSFET

PRODUC	CT SUMMARY		
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$ (Max.)	I <sub>D</sub> (A) <sup>f</sup>	Q <sub>g</sub> (Typ.)
30	0.0075 at V <sub>GS</sub> = 10 V	38.3	6.9 nC
30	0.0120 at V <sub>GS</sub> = 4.5 V	30.2	0.9110

## Thin PowerPAK® 1212-8 3 30 mm .30 mm

Ordering Information: SiS322DNT-T1-GE3 (Lead (Pb)-free and Halogen-free)

**Bottom View** 

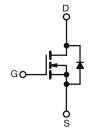
#### **FEATURES**

- TrenchFET® Gen IV Power MOSFET
- 100 %  $R_{\alpha}$  and UIS Tested
- Thin 0.75 mm height
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912



### **APPLICATIONS**

- Switch Mode Power Supplies
- Personal Computers and Servers
- Telecom Bricks
- VRM's and POL



N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATIN</b>	IGS (T <sub>A</sub> = 25 °C	, unless oth	erwise noted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		$V_{DS}$	30	V	
Gate-Source Voltage		$V_{GS}$	+ 20, - 16	1 °	
	T <sub>C</sub> = 25 °C		38.3		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	1 .	30.6		
Continuous Drain Current (1 <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	15.3 <sup>a, b</sup>	1	
	T <sub>A</sub> = 70 °C		12.1 <sup>a, b</sup>	Α	
Pulsed Drain Current (t = 300 μs)	-	I <sub>DM</sub>	70	<b>A</b>	
Ocation of Ocate Desire Disable Ocate	T <sub>C</sub> = 25 °C	I-	18		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	2.9 <sup>a, b</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	10		
Single Pulse Avalanche Energy	L = 0.1 IIII	E <sub>AS</sub>	5	mJ	
	T <sub>C</sub> = 25 °C		19.8		
Maximum Dawar Dissination	T <sub>C</sub> = 70 °C	P <sub>D</sub>	12.7	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	r <sub>D</sub>	3.2 <sup>a, b</sup>	- vv	
	T <sub>A</sub> = 70 °C		3 <sup>a, b</sup>		
Operating Junction and Storage Temperatur	e Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>c, d</sup>			260	]	

THERMAL RESISTANCE RA	TINGS				
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>a, e</sup>	t ≤ 10 s	R <sub>thJA</sub>	31	39	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	5	6.3	O/ V V

### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- c. See solder profile (www.vishav.com/doc?73257). The Thin PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Maximum under steady state conditions is 81 °C/W.
- f. Based on  $T_C = 25$  °C.

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### SiS322DNT

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	<u> </u>				l	<u> </u>
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 050 A		18.5		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5.2		mV/°
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	1.2		2.4	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = + 20 V, - 16 V			± 100	nA
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α
	, ,	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		0.0060	0.0075	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		0.0096	0.0120	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_{D} = 10 \text{ A}$		54		S
Dynamic <sup>b</sup>	l. I				l	
Input Capacitance	C <sub>iss</sub>			1000		
Output Capacitance	C <sub>oss</sub>			287		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		34		†
C <sub>rss</sub> /C <sub>iss</sub> Ratio				0.034	0.068	
	_	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		14.3	21.5	
Total Gate Charge	Qg			6.9	10.5	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		2.8		nC
Gate-Drain Charge	Q <sub>gd</sub>	30 30 2		1.6		-
Output Charge	Q <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V		7.8		
Gate Resistance	$R_{g}$	f = 1 MHz	0.4	1.6	3.2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			15	30	
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		10	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		15	30	1
Fall Time	t <sub>f</sub>			7	14	
Turn-On Delay Time	t <sub>d(on)</sub>			11	22	ns
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		9	18	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		15	30	
Fall Time	t <sub>f</sub>			5	10	
Drain-Source Body Diode Characteristic					l	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			18	Ι.
Pulse Diode Forward Current	I <sub>SM</sub>	-			70	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V		0.77	1.1	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- 45		19	35	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			7	14	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		10		+
Reverse Recovery Rise Time	t <sub>b</sub>			9		ns

### Notes:

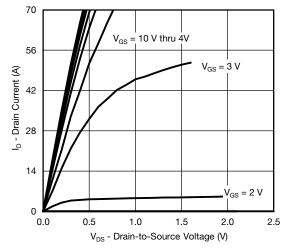
- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

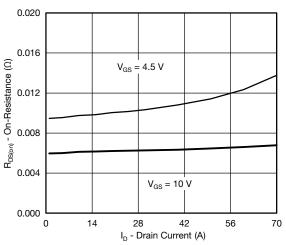


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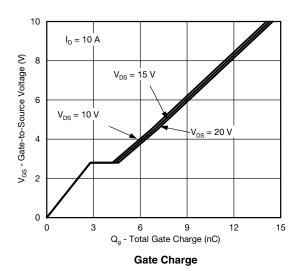
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

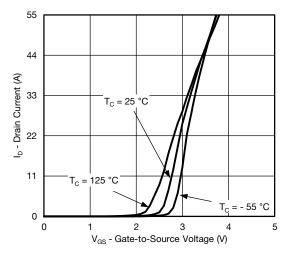


### **Output Characteristics**

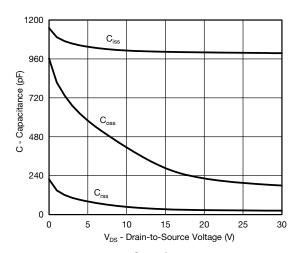


On-Resistance vs. Drain Current and Gate Voltage

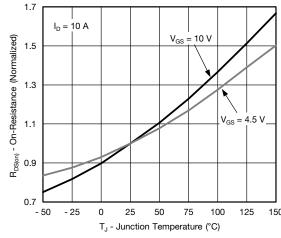




**Transfer Characteristics** 



Capacitance



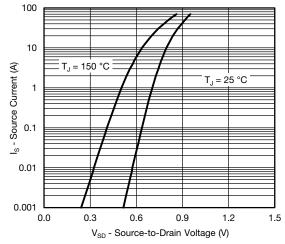
On-Resistance vs. Junction Temperature

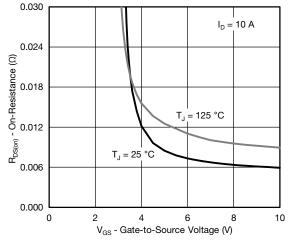
## SiS322DNT

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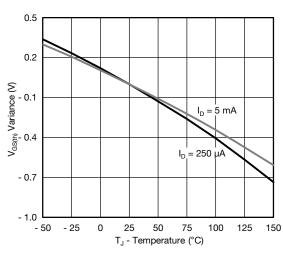
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

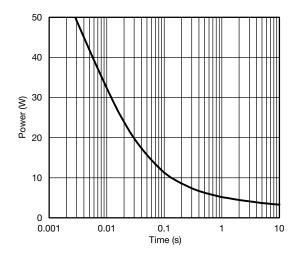




### Source-Drain Diode Forward Voltage

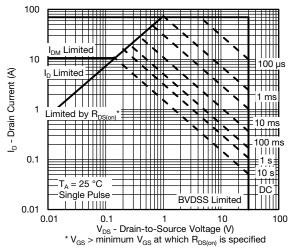
On-Resistance vs. Gate-to-Source Voltage





Threshold Voltage

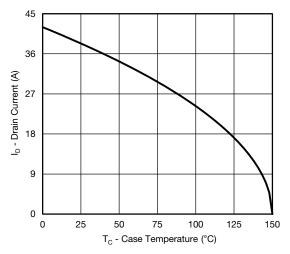
Single Pulse Power, Junction-to-Ambient



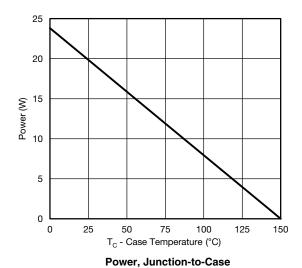


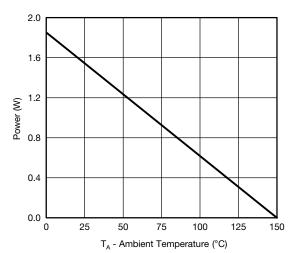
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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



### **Current Derating\***





Power, Junction-to-Ambient

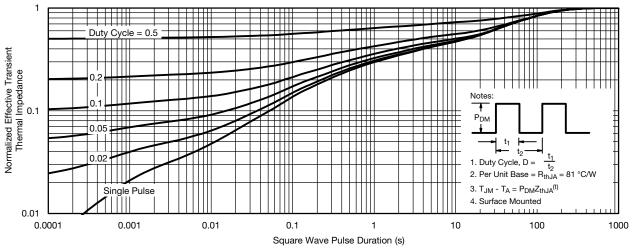
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

## SiS322DNT

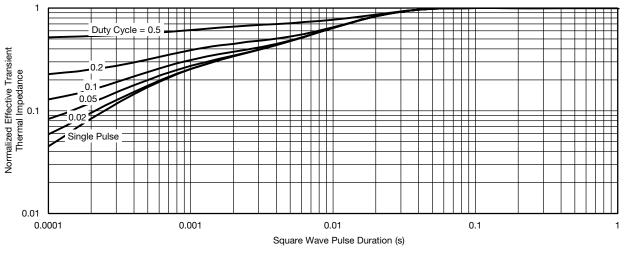
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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



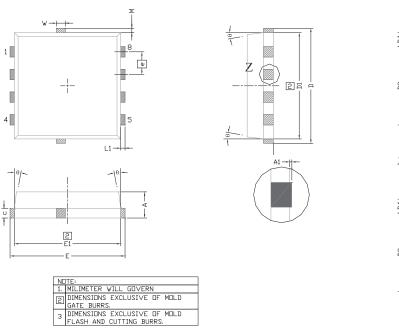
Normalized Thermal Transient Impedance, Junction-to-Case

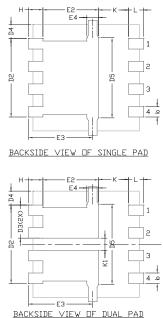
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63569.





## PowerPAK® 1212-8T





	MILLIMETERS				INCHES		
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
А	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00	-	0.05	0.000	-	0.002	
b	0.23	0.30	0.41	0.009	0.012	0.016	
С	0.23	0.28	0.33	0.009	0.011	0.013	
D	3.20	3.30	3.40	0.126	0.130	0.134	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
D3	0.48	-	0.89	0.019	-	0.035	
D4	0.47 TYP.			0.0185 TYP.			
D5		2.3 TYP.			0.090 TYP.		
Е	3.20	3.30	3.40	0.126	0.130	0.134	
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	1.75	1.85	1.98	0.069	0.073	0.078	
E4	0.34 TYP.			0.013 TYP.			
е	0.65 BSC			0.026 BSC			
K		0.86 TYP.		0.034 TYP.			
K1	0.35	=	-	0.014	-	-	
Н	0.30	0.41	0.51	0.012	0.016	0.020	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
θ	0°	-	12°	0°	-	12°	
W	0.15	0.25	0.36	0.006	0.010	0.014	
М	0.125 TYP.				0.005 TYP.		

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